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Embedded - Microcontrollers - Application Specific: Tailored Solutions for Precision and Performance

Embedded - Microcontrollers - Application Specific represents a category of microcontrollers designed with unique features and capabilities tailored to specific application needs. Unlike general-purpose microcontrollers, application-specific microcontrollers are optimized for particular tasks, offering enhanced performance, efficiency, and functionality to meet the demands of specialized applications.

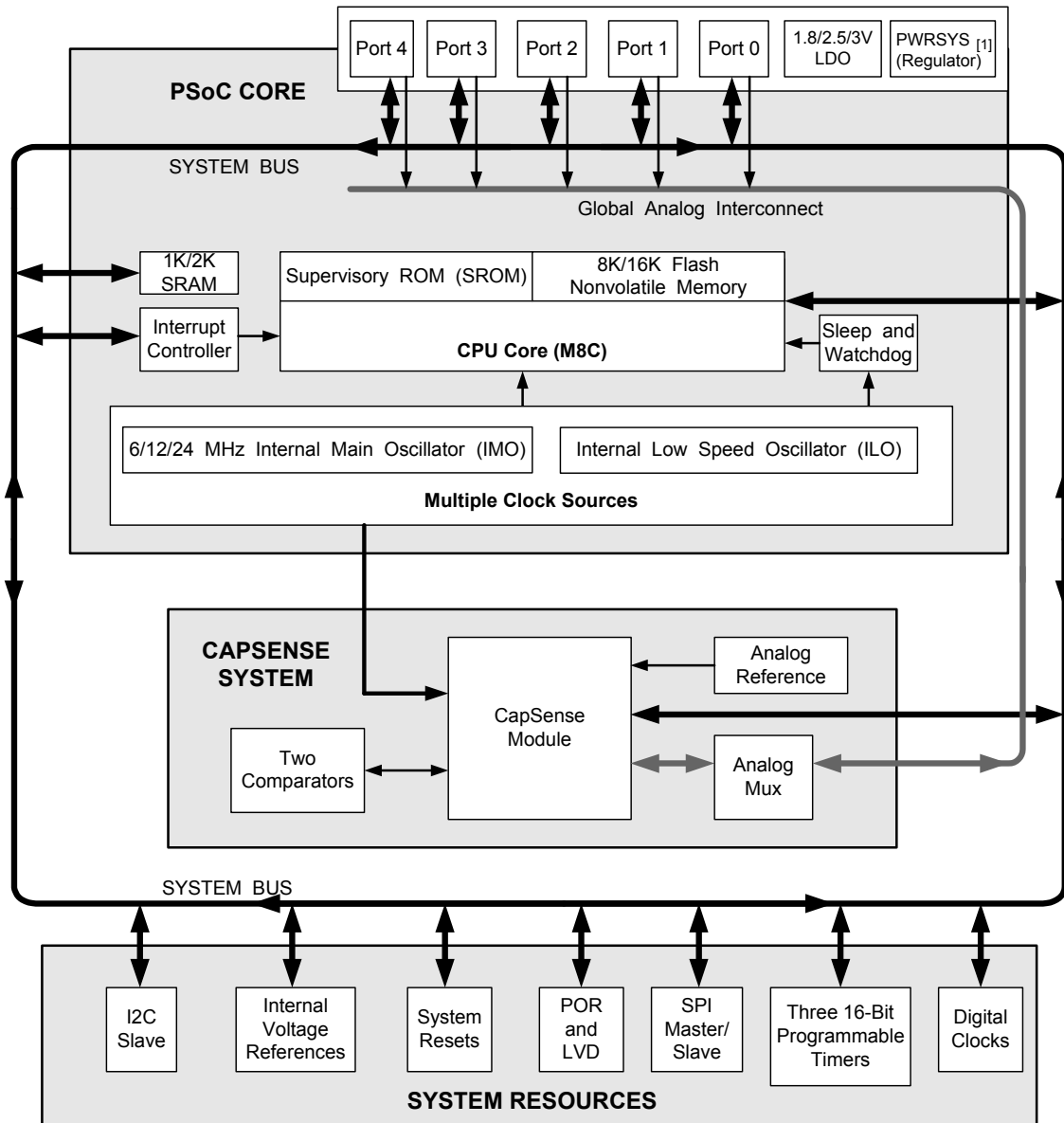
What Are Embedded - Microcontrollers - Application Specific?

Application specific microcontrollers are engineered to

Details

Product Status	Active
Applications	Capacitive Sensing
Core Processor	M8C
Program Memory Type	FLASH (16kB)
Controller Series	CY8C20xx6A
RAM Size	2K x 8
Interface	I ² C, SPI
Number of I/O	36
Voltage - Supply	1.71V ~ 5.5V
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	48-BSSOP (0.295", 7.50mm Width)
Supplier Device Package	48-SSOP
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c20546a-24pvxi

Logic Block Diagram



Note

1. Internal voltage regulator for internal circuitry

PSoC® Functional Overview

The PSoC family consists of on-chip controller devices, which are designed to replace multiple traditional microcontroller unit (MCU)-based components with one, low-cost single-chip programmable component. A PSoC device includes configurable analog and digital blocks, and programmable interconnect. This architecture allows the user to create customized peripheral configurations, to match the requirements of each individual application. Additionally, a fast CPU, flash program memory, SRAM data memory, and configurable I/O are included in a range of convenient pinouts.

The architecture for this device family, as shown in the [Logic Block Diagram on page 2](#), consists of three main areas:

- The core
- CapSense analog system
- System resources (including a full-speed USB port).

A common, versatile bus allows connection between the I/O and the analog system.

Each CY8C20336H/446H PSoC device includes a dedicated CapSense block that provides sensing and scanning control circuitry for capacitive sensing applications. Depending on the PSoC package, up to 28 GPIOs are also included. The GPIOs provide access to the MCU and analog mux.

PSoC Core

The PSoC core is a powerful engine that supports a rich instruction set. It encompasses SRAM for data storage, an interrupt controller, sleep and watchdog timers, and IMO and ILO. The CPU core, called the M8C, is a powerful processor with speeds up to 24 MHz. The M8C is a 4-MIPS, 8-bit Harvard-architecture microprocessor.

CapSense System

The analog system contains the capacitive sensing hardware. Several hardware algorithms are supported. This hardware performs capacitive sensing and scanning without requiring external components. The analog system is composed of the CapSense PSoC block and an internal 1-V or 1.2-V analog reference, which together support capacitive sensing of up to 28 inputs^[2]. Capacitive sensing is configurable on each GPIO pin. Scanning of enabled CapSense pins are completed quickly and easily across multiple ports.

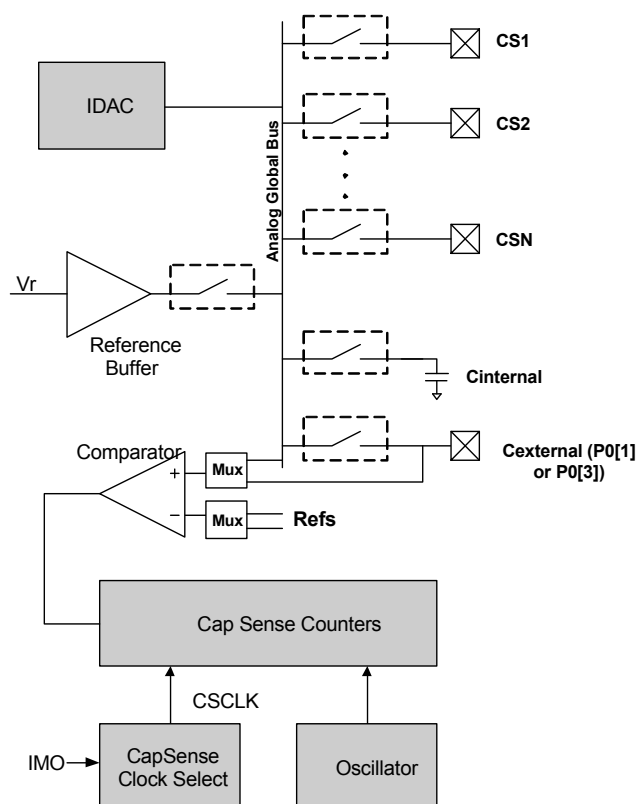
SmartSense™

SmartSense is an innovative solution from Cypress that removes manual tuning of CapSense applications. This solution is easy-to-use and provides a robust noise immunity. It is the only auto-tuning solution that establishes, monitors, and maintains all required tuning parameters. SmartSense allows engineers to go from prototyping to mass production without re-tuning for manufacturing variations in PCB and/or overlay material properties.

Note

2. 36 GPIOs = 33 pins for capacitive sensing + 2 pins for I²C + 1 pin for modulator capacitor.

Figure 1. CapSense System Block Diagram



Analog Multiplexer System

The analog mux bus can connect to every GPIO pin. Pins are connected to the bus individually or in any combination. The bus also connects to the analog system for analysis with the CapSense block comparator.

Switch-control logic enables selected pins to precharge continuously under hardware control. This enables capacitive measurement for applications such as touch sensing. Other multiplexer applications include:

- Complex capacitive sensing interfaces, such as sliders and touchpads.
- Chip-wide mux that allows analog input from any I/O pin.
- [Crosspoint connection](#) between any I/O pin combinations.

Haptics TS2000 Controller

The CY8C20336H/CY8C20446H family of devices feature an easy-to-use Haptics controller resource with up to 14 different effects. These effects are available for use with three different, selectable ERM modules.

Additional System Resources

System resources provide additional capability, such as configurable USB and I²C slave, SPI master/slave communication interface, three 16-bit programmable timers, and various system resets supported by the M8C.

These system resources provide additional capability useful to complete systems. Additional resources include low voltage detection and power on reset. The merits of each system resource are listed here:

- The I²C slave/SPI master-slave module provides 50/100/400 kHz communication over two wires. SPI communication over three or four wires runs at speeds of 46.9 kHz to 3 MHz (lower for a slower system clock).
- The I²C hardware address recognition feature reduces the already low power consumption by eliminating the need for CPU intervention until a packet addressed to the target device is received.
- The I²C enhanced slave interface appears as a 32-byte RAM buffer to the external I²C master. Using a simple predefined protocol, the master controls the read and write pointers into the RAM. When this method is enabled, the slave does not stall the bus when receiving data bytes in active mode. For usage details, refer to the application note [I2C Enhanced Slave Operation - AN56007](#).
- Low voltage detection (LVD) interrupts can signal the application of falling voltage levels, while the advanced power-on-reset (POR) circuit eliminates the need for a system supervisor.
- An internal reference provides an absolute reference for capacitive sensing.
- A register-controlled bypass mode allows the user to disable the LDO regulator.

Getting Started

For in depth information, along with detailed programming details, see the PSoC® [Technical Reference Manual](#).

For up-to-date ordering, packaging, and electrical specification information, see the latest [PSoC device datasheets](#) on the web.

Application Notes

[Cypress application notes](#) are an excellent introduction to the wide variety of possible PSoC designs.

Development Kits

[PSoC Development Kits](#) are available online from and through a growing number of regional and global distributors, which include Arrow, Avnet, Digi-Key, Farnell, Future Electronics, and Newark.

Training

[Free PSoC technical training](#) (on demand, webinars, and workshops), which is available online via www.cypress.com, covers a wide variety of topics and skill levels to assist you in your designs.

CYPros Consultants

Certified PSoC consultants offer everything from technical assistance to completed PSoC designs. To contact or become a PSoC consultant go to the [CYPros Consultants](#) web site.

Solutions Library

Visit our growing [library of solution focused designs](#). Here you can find various application designs that include firmware and hardware design files that enable you to complete your designs quickly.

Technical Support

[Technical support](#) – including a searchable Knowledge Base articles and technical forums – is also available online. If you cannot find an answer to your question, call our Technical Support hotline at 1-800-541-4736.

Designing with PSoC Designer

The development process for the PSoC device differs from that of a traditional fixed-function microprocessor. The configurable analog and digital hardware blocks give the PSoC architecture a unique flexibility that pays dividends in managing specification change during development and lowering inventory costs. These configurable resources, called PSoC blocks, have the ability to implement a wide variety of user-selectable functions. The PSoC development process is:

1. Select [user modules](#).
2. Configure user modules.
3. Organize and connect.
4. Generate, verify, and debug.

Select User Modules

PSoC Designer provides a library of prebuilt, pretested hardware peripheral components called “user modules.” User modules make selecting and implementing peripheral devices, both analog and digital, simple.

Configure User Modules

Each user module that you select establishes the basic register settings that implement the selected function. They also provide parameters and properties that allow you to tailor their precise configuration to your particular application. For example, a PWM User Module configures one or more digital PSoC blocks, one for each eight bits of resolution. Using these parameters, you can establish the pulse width and duty cycle. Configure the parameters and properties to correspond to your chosen application. Enter values directly or by selecting values from drop-down menus. All of the user modules are documented in datasheets that may be viewed directly in PSoC Designer or on the Cypress website. These [user module datasheets](#) explain the internal operation of the user module and provide performance specifications. Each datasheet describes the use of each user module parameter, and other information that you may need to successfully implement your design.

Organize and Connect

Build signal chains at the chip level by interconnecting user modules to each other and the I/O pins. Perform the selection, configuration, and routing so that you have complete control over all on-chip resources.

Generate, Verify, and Debug

When you are ready to test the hardware configuration or move on to developing code for the project, perform the “Generate Configuration Files” step. This causes PSoC Designer to generate source code that automatically configures the device to your specification and provides the software for the system. The generated code provides APIs with high-level functions to control and respond to hardware events at run time, and interrupt service routines that you can adapt as needed.

A complete code development environment lets you to develop and customize your applications in C, assembly language, or both.

The last step in the development process takes place inside PSoC Designer's Debugger (accessed by clicking the Connect icon). PSoC Designer downloads the HEX image to the ICE where it runs at full-speed. PSoC Designer debugging capabilities rival those of systems costing many times more. In addition to traditional single-step, run-to-breakpoint, and watch-variable features, the debug interface provides a large trace buffer. It lets you to define complex breakpoint events that include monitoring address and data bus values, memory locations, and external signals.

DC Chip-Level Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 6. DC Chip-Level Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
$V_{DD}^{[13]}$	Supply voltage	Refer the table DC POR and LVD Specifications on page 17	1.71	–	5.50	V
I_{DD24}	Supply current, IMO = 24 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 24 MHz. CapSense running at 12 MHz, no I/O sourcing current	–	3.32	4.00	mA
I_{DD12}	Supply current, IMO = 12 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 12 MHz. CapSense running at 12 MHz, no I/O sourcing current	–	1.86	2.60	mA
I_{DD6}	Supply current, IMO = 6 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 6 MHz. CapSense running at 6 MHz, no I/O sourcing current	–	1.13	1.80	mA
I_{SB0}	Deep sleep current	$V_{DD} \leq 3.0$ V, $T_A = 25$ °C, I/O regulator turned off	–	0.10	0.50	μA
I_{SB1}	Standby current with POR, LVD, and sleep timer	$V_{DD} \leq 3.0$ V, $T_A = 25$ °C, I/O regulator turned off	–	1.07	1.50	μA

Note

13. When V_{DD} remains in the range from 1.71 V to 1.9 V for more than 50 μsec, the slew rate when moving from the 1.71 V to 1.9 V range to greater than 2 V must be slower than 1 V/500 μsec to avoid triggering POR. The only other restriction on slew rates for any other voltage range or transition is the SR_{POWER_UP} parameter.

DC General Purpose I/O Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 3.0 V to 5.5 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, 2.4 V to 3.0 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, or 1.71 V to 2.4 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25 °C and are for design guidance only.

Table 7. 3.0 V to 5.5 V DC GPIO Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
R _{PU}	Pull-up resistor		4	5.60	8	kΩ
V _{OH1}	High output voltage port 2 or 3 pins	I _{OH} ≤ 10 μA, maximum of 10 mA source current in all I/Os	V _{DD} – 0.20	–	–	V
V _{OH2}	High output voltage port 2 or 3 pins	I _{OH} = 1 mA, maximum of 20 mA source current in all I/Os	V _{DD} – 0.90	–	–	V
V _{OH3}	High output voltage port 0 or 1 pins with LDO regulator disabled for port 1	I _{OH} < 10 μA, maximum of 10 mA source current in all I/Os	V _{DD} – 0.20	–	–	V
V _{OH4}	High output voltage port 0 or 1 pins with LDO regulator disabled for port 1	I _{OH} = 5 mA, maximum of 20 mA source current in all I/Os	V _{DD} – 0.90	–	–	V
V _{OH5}	High output voltage port 1 pins with LDO regulator enabled for 3 V out	I _{OH} < 10 μA, V _{DD} > 3.1 V, maximum of 4 I/Os all sourcing 5 mA	2.85	3.00	3.30	V
V _{OH6}	High output voltage port 1 pins with LDO regulator enabled for 3 V out	I _{OH} = 5 mA, V _{DD} > 3.1 V, maximum of 20 mA source current in all I/Os	2.20	–	–	V
V _{OH7}	High output voltage port 1 pins with LDO enabled for 2.5 V out	I _{OH} < 10 μA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	2.35	2.50	2.75	V
V _{OH8}	High output voltage port 1 pins with LDO enabled for 2.5 V out	I _{OH} = 2 mA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.90	–	–	V
V _{OH9}	High output voltage port 1 pins with LDO enabled for 1.8 V out	I _{OH} < 10 μA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.60	1.80	2.10	V
V _{OH10}	High output voltage port 1 pins with LDO enabled for 1.8 V out	I _{OH} = 1 mA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.20	–	–	V
V _{OL}	Low output voltage	I _{OL} = 25 mA, V _{DD} > 3.3 V, maximum of 60 mA sink current on even port pins (for example, P0[2] and P1[4]) and 60 mA sink current on odd port pins (for example, P0[3] and P1[5])	–	–	0.75	V
V _{IL}	Input low voltage		–	–	0.80	V
V _{IH}	Input high voltage		2.00	–	–	V
V _H	Input hysteresis voltage		–	80	–	mV
I _{IL}	Input leakage (absolute value)		–	0.001	1	μA
C _{PIN}	Pin capacitance	Package and pin dependent Temp = 25 °C	0.50	1.70	7	pF

Table 9. 1.71 V to 2.4 V DC GPIO Specifications (continued)

Symbol	Description	Conditions	Min	Typ	Max	Units
V_H	Input hysteresis voltage		–	80	–	mV
I_{IL}	Input leakage (absolute value)		–	1	1000	nA
C_{PIN}	Capacitive load on pins	Package and pin dependent Temp = 25 °C	0.50	1.70	7	pF

Table 10. DC Characteristics – USB Interface

Symbol	Description	Conditions	Min	Typ	Max	Units
Rusbi	USB D+ pull-up resistance	With idle bus	900	–	1575	Ω
Rusba	USB D+ pull-up resistance	While receiving traffic	1425	–	3090	Ω
Vohusb	Static output high		2.8	–	3.6	V
Volusb	Static output low		–	–	0.3	V
Vdi	Differential input sensitivity		0.2	–	–	V
Vcm	Differential input common mode range		0.8	–	2.5	V
Vse	Single-ended receiver threshold		0.8	–	2.0	V
Cin	Transceiver capacitance		–	–	50	pF
Iio	High-Z state data line leakage	On D+ or D- line	–10	–	+10	μ A
Rps2	PS/2 pull-up resistance		3000	5000	7000	Ω
Rext	External USB series resistor	In series with each USB pin	21.78	22.0	22.22	Ω

DC Analog Mux Bus Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 11. DC Analog Mux Bus Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
R_{SW}	Switch resistance to common analog bus		–	–	800	Ω
R_{GND}	Resistance of initialization switch to V_{SS}		–	–	800	Ω

The maximum pin voltage for measuring R_{SW} and R_{GND} is 1.8 V

DC Low Power Comparator Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 12. DC Comparator Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V_{LPC}	Low power comparator (LPC) common mode	Maximum voltage limited to V_{DD}	0.0	–	1.8	V
I_{LPC}	LPC supply current		–	10	40	μ A
V_{OSLPC}	LPC voltage offset		–	2.5	30	mV

Comparator User Module Electrical Specifications

The following table lists the guaranteed maximum and minimum specifications. Unless stated otherwise, the specifications are for the entire device voltage and temperature operating range: $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, $1.71\text{ V} \leq V_{DD} \leq 5.5\text{ V}$.

Table 13. Comparator User Module Electrical Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
T_{COMP}	Comparator response time	50-mV overdrive	–	70	100	ns
Offset		Valid from 0.2 V to $V_{DD} - 0.2\text{ V}$	–	2.5	30	mV
Current		Average DC current, 50 mV overdrive	–	20	80	μA
PSRR	Supply voltage > 2 V	Power supply rejection ratio	–	80	–	dB
	Supply voltage < 2 V	Power supply rejection ratio	–	40	–	dB
Input Range			0	–	1.5	V

ADC Electrical Specifications

Table 14. ADC User Module Electrical Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
Input						
V_{IN}	Input voltage range		0	–	V_{REFADC}	V
C_{IIN}	Input capacitance		–	–	5	pF
R_{IN}	Input resistance	Equivalent switched cap input resistance for 8-, 9-, or 10-bit resolution	$1/(500\text{fF} \times \text{data clock})$	$1/(400\text{fF} \times \text{data clock})$	$1/(300\text{fF} \times \text{data clock})$	Ω
Reference						
V_{REFADC}	ADC reference voltage		1.14	–	1.26	V
Conversion Rate						
F_{CLK}	Data clock	Source is chip's internal main oscillator. See AC Chip-Level Specifications on page 18 for accuracy	2.25	–	6	MHz
S8	8-bit sample rate	Data clock set to 6 MHz. Sample Rate = $0.001/(2^{\text{Resolution}}/\text{Data clock})$	–	23.43	–	ksps
S10	10-bit sample rate	Data clock set to 6 MHz. Sample Rate = $0.001/(2^{\text{Resolution}}/\text{Data clock})$	–	5.85	–	ksps
DC Accuracy						
RES	Resolution	Can be set to 8-, 9-, or 10-bit	8	–	10	bits
DNL	Differential nonlinearity		–1	–	+2	LSB
INL	Integral nonlinearity		–2	–	+2	LSB
E_{OFFSET}	Offset error	8-bit resolution	0	3.20	19.20	LSB
		10-bit resolution	0	12.80	76.80	LSB
E_{GAIN}	Gain error	For any resolution	–5	–	+5	%FSR
Power						
I_{ADC}	Operating current		–	2.10	2.60	mA
PSRR	Power supply rejection ratio	PSRR ($V_{DD} > 3.0\text{ V}$)	–	24	–	dB
		PSRR ($V_{DD} < 3.0\text{ V}$)	–	30	–	dB

DC POR and LVD Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 15. DC POR and LVD Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{POR0}	1.66 V selected in PSoC Designer	V _{DD} must be greater than or equal to 1.71 V during startup, reset from the XRES pin, or reset from watchdog.	1.61	1.66	1.71	V
V _{POR1}	2.36 V selected in PSoC Designer		–	2.36	2.41	
V _{POR2}	2.60 V selected in PSoC Designer		–	2.60	2.66	
V _{POR3}	2.82 V selected in PSoC Designer		–	2.82	2.95	
V _{LVD0}	2.45 V selected in PSoC Designer		2.40	2.45	2.51	V
V _{LVD1}	2.71 V selected in PSoC Designer		2.64 ^[14]	2.71	2.78	
V _{LVD2}	2.92 V selected in PSoC Designer		2.85 ^[15]	2.92	2.99	
V _{LVD3}	3.02 V selected in PSoC Designer		2.95 ^[16]	3.02	3.09	
V _{LVD4}	3.13 V selected in PSoC Designer		3.06	3.13	3.20	
V _{LVD5}	1.90 V selected in PSoC Designer		1.84	1.90	2.32	
V _{LVD6}	1.80 V selected in PSoC Designer		1.75 ^[17]	1.80	1.84	
V _{LVD7}	4.73 V selected in PSoC Designer		4.62	4.73	4.83	

DC Programming Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 16. DC Programming Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{DDIWRITE}	Supply voltage for flash write operations		1.71	–	5.25	V
I _{DDP}	Supply current during programming or verify		–	5	25	mA
V _{ILP}	Input low voltage during programming or verify	See the appropriate DC General Purpose I/O Specifications on page 13	–	–	V _{IL}	V
V _{IHP}	Input high voltage during programming or verify	See appropriate DC General Purpose I/O Specifications on page 13 table on pages 15 or 16	V _{IH}	–	–	V
I _{ILP}	Input current when applying V _{ILP} to P1[0] or P1[1] during programming or verify	Driving internal pull-down resistor	–	–	0.2	mA
I _{IHP}	Input current when applying V _{IHP} to P1[0] or P1[1] during programming or verify	Driving internal pull-down resistor	–	–	1.5	mA
V _{OLP}	Output low voltage during programming or verify		–	–	V _{SS} + 0.75	V
V _{OHP}	Output high voltage during programming or verify	See appropriate DC General Purpose I/O Specifications on page 13 table on page 16. For V _{DD} > 3 V use V _{OH4} in Table 5 on page 11 .	V _{OH}	–	V _{DD}	V
Flash _{ENPB}	Flash write endurance	Erase/write cycles per block	50,000	–	–	–
Flash _{DR}	Flash data retention	Following maximum flash write cycles; ambient temperature of 55 °C	10	20	–	Years

Notes

14. Always greater than 50 mV above V_{PPOR1} voltage for falling supply.
15. Always greater than 50 mV above V_{PPOR2} voltage for falling supply.
16. Always greater than 50 mV above V_{PPOR3} voltage for falling supply.
17. Always greater than 50 mV above V_{PPOR0} voltage for falling supply.

AC Chip-Level Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 17. AC Chip-Level Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F _{IMO24}	IMO frequency at 24-MHz setting		22.8	24	25.2	MHz
F _{IMO12}	IMO frequency at 12-MHz setting		11.4	12	12.6	MHz
F _{IMO6}	IMO frequency at 6-MHz setting		5.7	6.0	6.3	MHz
F _{CPU}	CPU frequency		0.75	–	25.20	MHz
F _{32K1}	ILO frequency		19	32	50	kHz
F _{32K_U}	ILO untrimmed frequency		13	32	82	kHz
DC _{IMO}	Duty cycle of IMO		40	50	60	%
DC _{ILO}	ILO duty cycle		40	50	60	%
SR _{POWER_UP}	Power supply slew rate	V _{DD} slew rate during power-up	–	–	250	V/ms
T _{XRST}	External reset pulse width at power-up	After supply voltage is valid	1	–	–	ms
T _{XRST2}	External reset pulse width after power-up ^[18]	Applies after part has booted	10	–	–	μs

Note

18. The minimum required XRES pulse length is longer when programming the device (see [Table 23 on page 21](#)).

AC General Purpose I/O Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 18. AC GPIO Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{GPIO}	GPIO operating frequency	Normal strong mode port 0, 1	0	–	6 MHz for 1.71 V < V_{DD} < 2.40 V 12 MHz for 2.40 V < V_{DD} < 5.50 V	MHz
T_{RISE23}	Rise time, strong mode, Cload = 50 pF ports 2 or 3	V_{DD} = 3.0 to 3.6 V, 10% – 90%	15	–	80	ns
$T_{RISE23L}$	Rise time, strong mode low supply, Clload = 50 pF, ports 2 or 3	V_{DD} = 1.71 to 3.0 V, 10% – 90%	15	–	80	ns
T_{RISE01}	Rise time, strong mode, Clload = 50 pF ports 0 or 1	V_{DD} = 3.0 to 3.6 V, 10% – 90% LDO enabled or disabled	10	–	50	ns
$T_{RISE01L}$	Rise time, strong mode low supply, Clload = 50 pF, ports 0 or 1	V_{DD} = 1.71 to 3.0 V, 10% – 90% LDO enabled or disabled	10	–	80	ns
T_{FALL}	Fall time, strong mode, Clload = 50 pF all ports	V_{DD} = 3.0 to 3.6 V, 10% – 90%	10	–	50	ns
T_{FALLL}	Fall time, strong mode low supply, Clload = 50 pF, all ports	V_{DD} = 1.71 to 3.0 V, 10% – 90%	10	–	70	ns

Figure 6. GPIO Timing Diagram

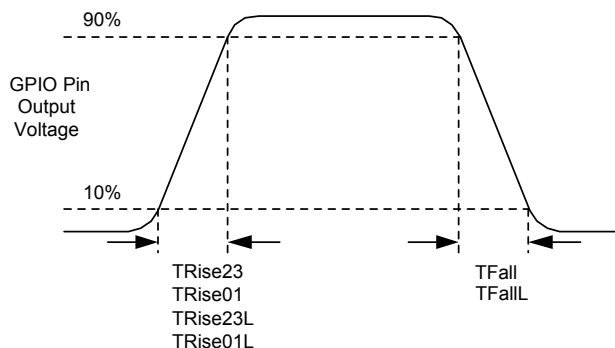


Table 19. AC Characteristics – USB Data Timings

Symbol	Description	Conditions	Min	Typ	Max	Units
T _{DRATE}	Full-speed data rate	Average bit rate	12 – 0.25%	12	12 + 0.25%	MHz
T _{JR1}	Receiver jitter tolerance	To next transition	–18.5	–	18.5	ns
T _{JR2}	Receiver jitter tolerance	To pair transition	–9	–	9	ns
T _{DJ1}	FS driver jitter	To next transition	–3.5	–	3.5	ns
T _{DJ2}	FS driver jitter	To pair transition	–4.0	–	4.0	ns
T _{FDEOP}	Source jitter for differential transition	To SE0 transition	–2	–	5	ns
T _{FEOPT}	Source SE0 interval of EOP		160	–	175	ns
T _{FEOPR}	Receiver SE0 interval of EOP		82	–		ns
T _{FST}	Width of SE0 interval during differential transition		–	–	14	ns

Table 20. AC Characteristics – USB Driver

Symbol	Description	Conditions	Min	Typ	Max	Units
T _{FR}	Transition rise time	50 pF	4	–	20	ns
T _{FF}	Transition fall time	50 pF	4	–	20	ns
T _{FRFM} ^[19]	Rise/fall time matching		90	–	111	%
V _{crs}	Output signal crossover voltage		1.30	–	2.00	V

AC Comparator Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 21. AC Low Power Comparator Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
T _{LPC}	Comparator response time, 50 mV overdrive	50 mV overdrive does not include offset voltage.	–	–	100	ns

AC External Clock Specifications

The following table lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 22. AC External Clock Specifications

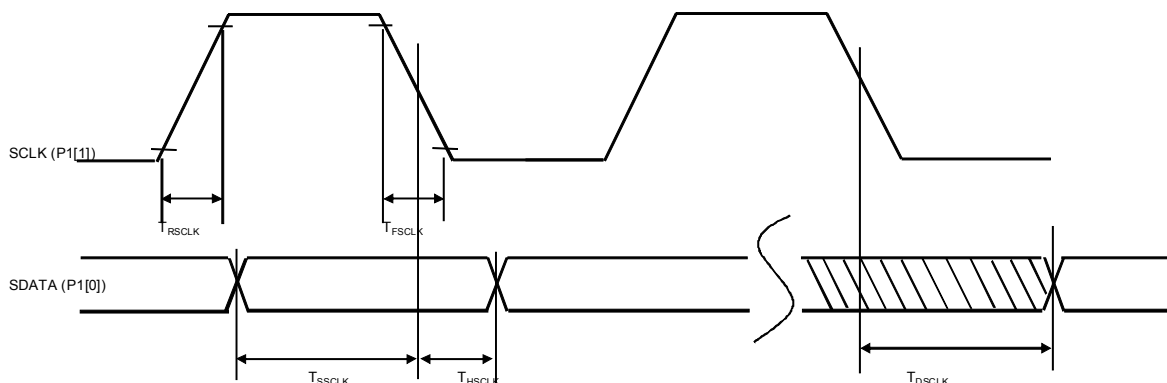
Symbol	Description	Conditions	Min	Typ	Max	Units
F _{OSCEXT}	Frequency (external oscillator frequency)		0.75	–	25.20	MHz
	High period		20.60	–	5300	ns
	Low period		20.60	–	–	ns
	Power-up IMO to switch		150	–	–	μs

Note

19. T_{FRFM} is not met under all conditions. There is a corner case at lower supply voltages, such as those under 3.3 V. This condition does not affect USB communications. Signal integrity tests show an excellent eye diagram at 3.15 V.

AC Programming Specifications

Figure 7. AC Waveform



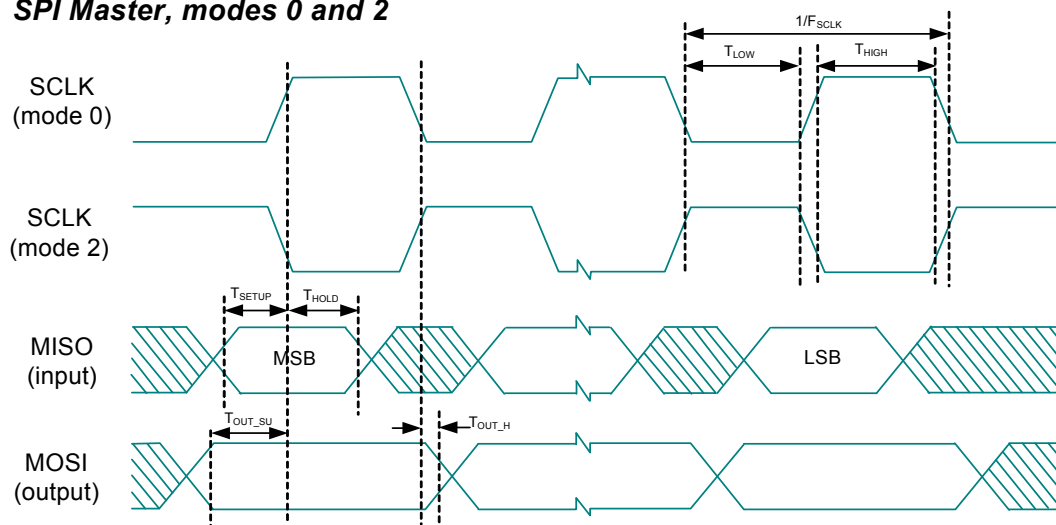
The following table lists the guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 23. AC Programming Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
T_{RCLK}	Rise time of SCLK		1	–	20	ns
T_{FCLK}	Fall time of SCLK		1	–	20	ns
T_{SSCLK}	Data Setup time to falling edge of SCLK		40	–	–	ns
T_{HSCLK}	Data Hold time from falling edge of SCLK		40	–	–	ns
F_{SCLK}	Frequency of SCLK		0	–	8	MHz
T_{ERASEB}	Flash erase time (Block)		–	–	18	ms
T_{WRITE}	Flash block write time		–	–	25	ms
T_{DSCLK}	Data out delay from falling edge of SCLK	$3.6 < V_{DD}$	–	–	60	ns
T_{DSCLK3}	Data out delay from falling edge of SCLK	$3.0 \leq V_{DD} \leq 3.6$	–	–	85	ns
T_{DSCLK2}	Data out delay from falling edge of SCLK	$1.71 \leq V_{DD} \leq 3.0$	–	–	130	ns
T_{XRST3}	External reset pulse width after power-up	Required to enter programming mode when coming out of sleep	300	–	–	μ s
T_{XRES}	XRES Pulse Length		300	–	–	μ s
$T_{VDDWAIT}$	V_{DD} stable to wait-and-poll hold off		0.1	–	1	ms
$T_{VDDXRES}$	V_{DD} stable to XRES assertion delay		14.27	–	–	ms
T_{POLL}	SDATA high pulse time		0.01	–	200	ms
T_{ACQ}	“Key window” time after a V_{DD} ramp acquire event, based on 256 ILO clocks.		3.20	–	19.60	ms
$T_{XRESINI}$	“Key window” time after an XRES event, based on eight ILO clocks		98	–	615	μ s

Table 25. SPI Master AC Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	$V_{DD} \geq 2.4 \text{ V}$ $V_{DD} < 2.4 \text{ V}$	— —	— —	6 3	MHz
DC	SCLK duty cycle		—	50	—	%
T_{SETUP}	MISO to SCLK setup time	$V_{DD} \geq 2.4 \text{ V}$ $V_{DD} < 2.4 \text{ V}$	60 100	— —	— —	ns
T_{HOLD}	SCLK to MISO hold time		40	—	—	ns
T_{OUT_VAL}	SCLK to MOSI valid time		—	—	40	ns
T_{OUT_H}	MOSI high time		40	—	—	ns

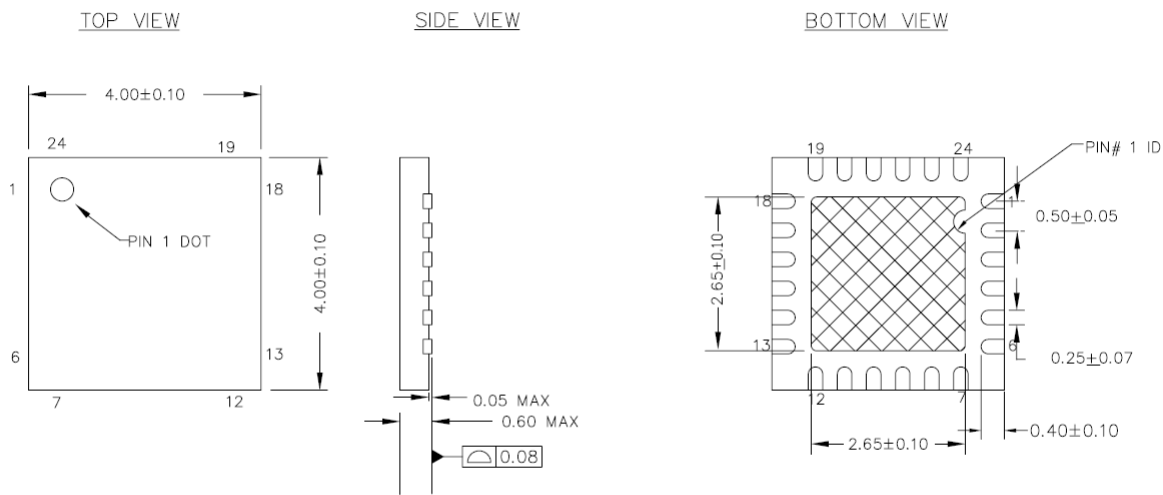
Figure 9. SPI Master Mode 0 and 2
SPI Master, modes 0 and 2


Packaging Information


This section illustrates the packaging specifications for the CY8C20336H/CY8C20446H PSoC device, along with the thermal impedances for each package.

Important Note Emulation tools may require a larger area on the target PCB than the chip's footprint. For a detailed description of the emulation tools' dimensions, refer to the document titled *PSoC Emulator Pod Dimensions* at <http://www.cypress.com/design/MR10161>.

Figure 13. 24-Pin ($4 \times 4 \times 0.55$ mm) QFN



NOTES :

1.  HATCH IS SOLDERABLE EXPOSED METAL.
2. REFERENCE JEDEC # MO-248
3. PACKAGE WEIGHT : 29 ± 3 mg
4. ALL DIMENSIONS ARE IN MILLIMETERS

001-13937 *E

Thermal Impedances

Table 27. Thermal Impedances per Package

Package	Typical θ_{JA} ^[21]
24-QFN ^[22]	20.90 °C/W
32-QFN ^[22]	19.51 °C/W
48-QFN ^[22]	17.68 °C/W

Capacitance on Crystal Pins

Table 28. Typical Package Capacitance on Crystal Pins

Package	Package Capacitance
32-pin QFN	3.2 pF
48-pin QFN	3.3 pF

Solder Reflow Peak Temperature

This table lists the minimum solder reflow peak temperature to achieve good solderability.

Table 29. Solder Reflow Peak Temperature

Package	Maximum Peak Temperature	Time at Maximum Peak Temperature
24-pin QFN	260 °C	30 s
32-pin QFN	260 °C	30 s
48-pin QFN	260 °C	30 s

Notes

21. $T_J = T_A + \text{Power} \times \theta_{JA}$.

22. To achieve the thermal impedance specified for the QFN package, the center thermal pad must be soldered to the PCB ground plane.

23. Higher temperatures may be required based on the solder melting point. Typical temperatures for solder are 220 ± 5 °C with Sn-Pb or 245 ± 5 °C with Sn-Ag-Cu paste. Refer to the solder manufacturer specifications.

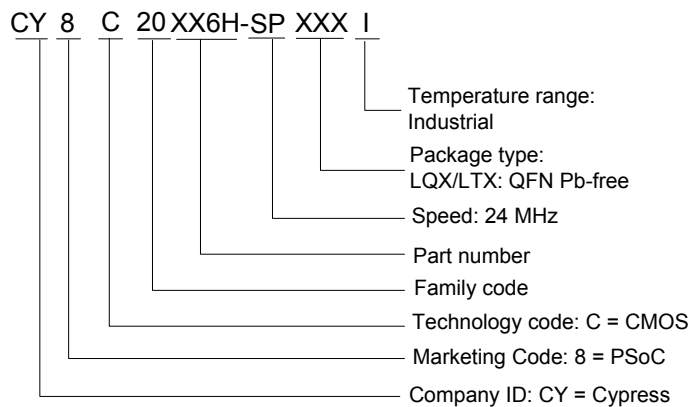
Ordering Information

The following table lists the CY8C20336H/CY8C20446H PSoC devices' key package features and ordering codes.

Table 31. PSoC Device Key Features and Ordering Information

Package	Ordering Code	Flash (KB)	SRAM (KB)	CapSense Blocks	Digital I/O Pins	Analog Inputs ^[27]	XRES Pin	USB
24-pin (4 × 4 × 0.6mm) QFN	CY8C20336H-24LQXI	8	1	1	20	20	Yes	No
32 pin (5 × 5 × 0.6 mm) QFN	CY8C20446H-24LQXI	16	2	1	28	28	Yes	No
48 pin (7 × 7 mm) QFN (OCD) ^[28]	CY8C20066A-24LTXI	32	2	1	36	36	Yes	Yes

Ordering Code Definitions



Document Conventions

Acronyms Used

The following table lists the acronyms that are used in this document.

Acronym	Description
AC	alternating current
ADC	analog-to-digital converter
API	application programming interface
CMOS	complementary metal oxide semiconductor
CPU	central processing unit
DAC	digital-to-analog converter
DC	direct current
EOP	end of packet
FSR	full scale range
GPIO	general purpose input/output
GUI	graphical user interface
I ² C	inter-integrated circuit
ICE	in-circuit emulator
IDAC	digital analog converter current
ILO	internal low speed oscillator
IMO	internal main oscillator
I/O	input/output
ISSP	in-system serial programming
LCD	liquid crystal display
LDO	low dropout (regulator)
LSB	least-significant bit
LVD	low voltage detect
MCU	micro-controller unit
MIPS	mega instructions per second
MISO	master in slave out
MOSI	master out slave in
MSB	most-significant bit
OCD	on-chip debugger
POR	power on reset
PPOR	precision power on reset
PSRR	power supply rejection ratio
PWRSYS	power system
PSoC®	Programmable System-on-Chip
SLIMO	slow internal main oscillator
SRAM	static random access memory
SNR	signal to noise ratio
QFN	quad flat no-lead
SCL	serial I ² C clock
SDA	serial I ² C data
SDATA	serial ISSP data
SPI	serial peripheral interface
SS	slave select
SSOP	shrink small outline package
TC	test controller
USB	universal serial bus
USB D+	USB Data +
USB D-	USB Data-
WLCSP	wafer level chip scale package
XTAL	crystal

Units of Measure

Table 32 lists all the abbreviations used to measure the PSoC devices.

Numeric Naming

Hexadecimal numbers are represented with all letters in uppercase with an appended lowercase 'h' (for example, '14h' or '3Ah'). Hexadecimal numbers may also be represented by a '0x' prefix, the C coding convention. Binary numbers have an appended lowercase 'b' (for example, '01010100b' or '01000011b'). Numbers not indicated by an 'h', 'b', or 0x are decimal.

Table 32. Units of Measure

Symbol	Unit of Measure
°C	degree Celsius
dB	decibels
fF	femto farad
g	gram
Hz	hertz
KB	1024 bytes
Kbit	1024 bits
KHz	kilohertz
Ksps	kilo samples per second
kΩ	kilohm
MHz	megahertz
MΩ	megaohm
μA	microampere
μF	microfarad
μH	microhenry
μs	microsecond
μW	microwatts
mA	milli-ampere
ms	milli-second
mV	milli-volts
nA	nanoampere
ns	nanosecond
nV	nanovolts
Ω	ohm
pA	picoampere
pF	picofarad
pp	peak-to-peak
ppm	parts per million
ps	picosecond
sps	samples per second
σ	sigma: one standard deviation
V	volts
W	watt

Glossary

Crosspoint connection	Connection between any GPIO combination via analog multiplexer bus.
Differential non-linearity	Ideally, any two adjacent digital codes correspond to output analog voltages that are exactly one LSB apart. Differential non-linearity is a measure of the worst case deviation from the ideal 1 LSB step.
Hold time	Hold time is the time following a clock event during which the data input to a latch or flip-flop must remain stable in order to guarantee that the latched data is correct.
I²C	It is a serial multi-master bus used to connect low speed peripherals to MCU.
Integral nonlinearity	It is a term describing the maximum deviation between the ideal output of a DAC/ADC and the actual output level.
Latch up current	Current at which the latch up test is conducted according to JESD78 standard (at 125 °C)
Power supply rejection ratio (PSRR)	The PSRR is defined as the ratio of the change in supply voltage to the corresponding change in output voltage of the device.
Scan	The conversion of all sensor capacitances to digital values.
Setup time	Period required to prepare a device, machine, process, or system for it to be ready to function.
Signal-to-noise ratio	The ratio between a capacitive finger signal and system noise.
SPI	Serial peripheral interface is a synchronous serial data link standard.

Reference Documents

- Technical reference manual for [CY8C20xx6](#) devices
- In-system Serial Programming (ISSP) protocol for 20xx6 – [AN2026C](#)
- Host Sourced Serial Programming for 20xx6 devices – [AN59389](#)

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